

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination FUJITA, ATSUSHI	
		Examiner	Art Unit	Page 1 of 1
		Devona E. Faulk	2644	

U.S. PATENT DOCUMENTS

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FOREIGN PATENT DOCUMENTS

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	N	JP 08293159 A	11-1996	Japan	MATSUMOTO et al.	G11B 20/10
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